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Understanding [Embedded - Microprocessors](#)

Embedded microprocessors are specialized computing chips designed to perform specific tasks within an embedded system. Unlike general-purpose microprocessors found in personal computers, embedded microprocessors are tailored for dedicated functions within larger systems, offering optimized performance, efficiency, and reliability. These microprocessors are integral to the operation of countless electronic devices, providing the computational power necessary for controlling processes, handling data, and managing communications.

Applications of [Embedded - Microprocessors](#)

Embedded microprocessors are utilized across a broad spectrum of applications, making them indispensable in

Details

Product Status	Obsolete
Core Processor	PowerPC e500
Number of Cores/Bus Width	1 Core, 32-Bit
Speed	833MHz
Co-Processors/DSP	Communications; CPM
RAM Controllers	DDR, SDRAM
Graphics Acceleration	No
Display & Interface Controllers	-
Ethernet	10/100/1000Mbps (2)
SATA	-
USB	USB 2.0 (1)
Voltage - I/O	2.5V, 3.3V
Operating Temperature	0°C ~ 105°C (TA)
Security Features	-
Package / Case	783-BBGA, FCBGA
Supplier Device Package	783-FCPBGA (29x29)
Purchase URL	https://www.e-xfl.com/product-detail/nxp-semiconductors/kmpc8555vtapf

- Two full-duplex fast communications controllers (FCCs) that support the following protocols:
 - ATM protocol through two UTOPIA level 2 interfaces
 - IEEE Std 802.3™/Fast Ethernet (10/100)
 - HDLC
 - Totally transparent operation
- Three full-duplex serial communications controllers (SCCs) support the following protocols:
 - High level/synchronous data link control (HDLC/SDLC)
 - LocalTalk (HDLC-based local area network protocol)
 - Universal asynchronous receiver transmitter (UART)
 - Synchronous UART (1x clock mode)
 - Binary synchronous communication (BISYNC)
 - Totally transparent operation
 - QMC support, providing 64 channels per SCC using only one physical TDM interface
- Universal serial bus (USB) controller that is full/low-speed compliant (multiplexed on an SCC)
 - USB host mode
 - Supports USB slave mode
- Serial peripheral interface (SPI) support for master or slave
- I²C bus controller
- Two serial management controllers (SMCs) supporting:
 - UART
 - Transparent
 - General-circuit interfaces (GCI)
- Time-slot assigner supports multiplexing of data from any of the SCCs and FCCs onto eight time-division multiplexed (TDM) interfaces. The time-slot assigner supports the following TDM formats:
 - T1/CEPT lines
 - T3/E3
 - Pulse code modulation (PCM) highway interface
 - ISDN primary rate
 - Freescale interchip digital link (IDL)
 - General circuit interface (GCI)
- User-defined interfaces
- Eight independent baud rate generators (BRGs)
- Four general-purpose 16-bit timers or two 32-bit timers
- General-purpose parallel ports—16 parallel I/O lines with interrupt capability
- 256 Kbytes of on-chip memory
 - Can act as a 256-Kbyte level-2 cache
 - Can act as a 256-Kbyte or two 128-Kbyte memory-mapped SRAM arrays

Items on the same line have no ordering requirement with respect to one another. Items on separate lines must be ordered sequentially such that voltage rails on a previous step must reach 90 percent of their value before the voltage rails on the current step reach ten percent of theirs.

NOTE

If the items on line 2 must precede items on line 1, please ensure that the delay does not exceed 500 ms and the power sequence is not done greater than once per day in production environment.

NOTE

From a system standpoint, if the I/O power supplies ramp prior to the V_{DD} core supply, the I/Os on the MPC8555E may drive a logic one or zero during power-up.

2.1.3 Recommended Operating Conditions

Table 2 provides the recommended operating conditions for the MPC8555E. Note that the values in Table 2 are the recommended and tested operating conditions. Proper device operation outside of these conditions is not guaranteed.

Table 2. Recommended Operating Conditions

Characteristic		Symbol	Recommended Value	Unit
Core supply voltage		V_{DD}	1.2 V \pm 60 mV 1.3 V \pm 50 mV (for 1 GHz only)	V
PLL supply voltage		AV_{DD}	1.2 V \pm 60 mV 1.3 V \pm 50 mV (for 1 GHz only)	V
DDR DRAM I/O voltage		GV_{DD}	2.5 V \pm 125 mV	V
Three-speed Ethernet I/O voltage		LV_{DD}	3.3 V \pm 165 mV 2.5 V \pm 125 mV	V
PCI, local bus, DUART, system control and power management, I ² C, and JTAG I/O voltage		OV_{DD}	3.3 V \pm 165 mV	V
Input voltage	DDR DRAM signals	MV_{IN}	GND to GV_{DD}	V
	DDR DRAM reference	MV_{REF}	GND to GV_{DD}	V
	Three-speed Ethernet signals	LV_{IN}	GND to LV_{DD}	V
	PCI, local bus, DUART, SYSCLK, system control and power management, I ² C, and JTAG signals	OV_{IN}	GND to OV_{DD}	V
Die-junction Temperature		T_j	0 to 105	°C

4.3 Real Time Clock Timing

Table 8 provides the real time clock (RTC) AC timing specifications.

Table 8. RTC AC Timing Specifications

Parameter/Condition	Symbol	Min	Typical	Max	Unit	Notes
RTC clock high time	t_{RTCH}	2 x t_{CCB_CLK}	—	—	ns	—
RTC clock low time	t_{RTCL}	2 x t_{CCB_CLK}	—	—	ns	—

5 RESET Initialization

This section describes the AC electrical specifications for the RESET initialization timing requirements of the MPC8555E. Table 9 provides the RESET initialization AC timing specifications.

Table 9. RESET Initialization Timing Specifications

Parameter/Condition	Min	Max	Unit	Notes
Required assertion time of \overline{HRESET}	100	—	μs	—
Minimum assertion time for \overline{SRESET}	512	—	SYSCLKs	1
PLL input setup time with stable SYSCLK before \overline{HRESET} negation	100	—	μs	—
Input setup time for POR configs (other than PLL config) with respect to negation of \overline{HRESET}	4	—	SYSCLKs	1
Input hold time for POR configs (including PLL config) with respect to negation of \overline{HRESET}	2	—	SYSCLKs	1
Maximum valid-to-high impedance time for actively driven POR configs with respect to negation of \overline{HRESET}	—	5	SYSCLKs	1

Notes:

1. SYSCLK is identical to the PCI_CLK signal and is the primary clock input for the MPC8555E. See the *MPC8555E PowerQUICC™ III Integrated Communications Processor Reference Manual* for more details.

Table 10 provides the PLL and DLL lock times.

Table 10. PLL and DLL Lock Times

Parameter/Condition	Min	Max	Unit	Notes
PLL lock times	—	100	μs	—
DLL lock times	7680	122,880	CCB Clocks	1, 2

Notes:

1. DLL lock times are a function of the ratio between the output clock and the platform (or CCB) clock. A 2:1 ratio results in the minimum and an 8:1 ratio results in the maximum.
2. The CCB clock is determined by the $SYSCLK \times \text{platform PLL ratio}$.

Table 14. DDR SDRAM Output AC Timing Specifications for Source Synchronous Mode (continued)

At recommended operating conditions with GV_{DD} of 2.5 V \pm 5%.

Parameter	Symbol ¹	Min	Max	Unit	Notes
MCS(n) output hold with respect to MCK 333 MHz 266 MHz 200 MHz	t_{DDKHCX}	2.0 2.65 3.8	—	ns	4
MCK to MDQS 333 MHz 266 MHz 200 MHz	t_{DDKMHM}	−0.9 −1.1 −1.2	0.3 0.5 0.6	ns	5
MDQ/MECC/MDM output setup with respect to MDQS 333 MHz 266 MHz 200 MHz	t_{DDKHDS} , t_{DDKLDS}	900 900 1200	—	ps	6
MDQ/MECC/MDM output hold with respect to MDQS 333 MHz 266 MHz 200 MHz	t_{DDKHDX} , t_{DDKLDX}	900 900 1200	—	ps	6
MDQS preamble start	t_{DDKHMP}	$−0.5 \times t_{MCK} − 0.9$	$−0.5 \times t_{MCK} + 0.3$	ns	7
MDQS epilogue end	t_{DDKLME}	−0.9	0.3	ns	7

Notes:

- The symbols used for timing specifications follow the pattern of $t_{(first\ two\ letters\ of\ functional\ block)(signal)(state)\ (reference)(state)}$ for inputs and $t_{(first\ two\ letters\ of\ functional\ block)(reference)(state)(signal)(state)}$ for outputs. Output hold time can be read as DDR timing (DD) from the rising or falling edge of the reference clock (KH or KL) until the output went invalid (AX or DX). For example, t_{DDKHAS} symbolizes DDR timing (DD) for the time t_{MCK} memory clock reference (K) goes from the high (H) state until outputs (A) are setup (S) or output valid time. Also, t_{DDKLDX} symbolizes DDR timing (DD) for the time t_{MCK} memory clock reference (K) goes low (L) until data outputs (D) are invalid (X) or data output hold time.
- All MCK/ \overline{MCK} referenced measurements are made from the crossing of the two signals ± 0.1 V.
- In the source synchronous mode, MCK/ \overline{MCK} can be shifted in 1/4 applied cycle increments through the Clock Control Register. For the skew measurements referenced for t_{AOSKEW} it is assumed that the clock adjustment is set to align the address/command valid with the rising edge of MCK.
- ADDR/CMD includes all DDR SDRAM output signals except MCK/ \overline{MCK} , \overline{MCS} , and MDQ/MECC/MDM/MDQS. For the ADDR/CMD setup and hold specifications, it is assumed that the Clock Control register is set to adjust the memory clocks by 1/2 applied cycle. The MCSx pins are separated from the ADDR/CMD (address and command) bus in the HW spec. This was separated because the MCSx pins typically have different loadings than the rest of the address and command bus, even though they have the same timings.
- Note that t_{DDKMHM} follows the symbol conventions described in note 1. For example, t_{DDKMHM} describes the DDR timing (DD) from the rising edge of the MCK(n) clock (KH) until the MDQS signal is valid (MH). In the source synchronous mode, MDQS can launch later than MCK by 0.3 ns at the maximum. However, MCK may launch later than MDQS by as much as 0.9 ns. t_{DDKMHM} can be modified through control of the DQSS override bits in the TIMING_CFG_2 register. In source synchronous mode, this typically is set to the same delay as the clock adjust in the CLK_CNTL register. The timing parameters listed in the table assume that these two parameters have been set to the same adjustment value. See the *MPC8555E PowerQUICC™ III Integrated Communications Processor Reference Manual* for a description and understanding of the timing modifications enabled by use of these bits.
- Determined by maximum possible skew between a data strobe (MDQS) and any corresponding bit of data (MDQ), ECC (MECC), or data mask (MDM). The data strobe should be centered inside of the data eye at the pins of the MPC8555E.
- All outputs are referenced to the rising edge of MCK(n) at the pins of the MPC8555E. Note that t_{DDKHMP} follows the symbol conventions described in note 1.

7.2 DUART AC Electrical Specifications

Table 17 provides the AC timing parameters for the DUART interface of the MPC8555E.

Table 17. DUART AC Timing Specifications

Parameter	Value	Unit	Notes
Minimum baud rate	$f_{\text{CCB_CLK}} / 1048576$	baud	3
Maximum baud rate	$f_{\text{CCB_CLK}} / 16$	baud	1, 3
Oversample rate	16	—	2, 3

Notes:

1. Actual attainable baud rate is limited by the latency of interrupt processing.
2. The middle of a start bit is detected as the 8th sampled 0 after the 1-to-0 transition of the start bit. Subsequent bit values are sampled each 16th sample.
3. Guaranteed by design.

8 Ethernet: Three-Speed, MII Management

This section provides the AC and DC electrical characteristics for three-speed, 10/100/1000, and MII management.

8.1 Three-Speed Ethernet Controller (TSEC) (10/100/1000 Mbps)—GMII/MII/TBI/RGMII/RTBI Electrical Characteristics

The electrical characteristics specified here apply to all GMII (gigabit media independent interface), the MII (media independent interface), TBI (ten-bit interface), RGMII (reduced gigabit media independent interface), and RTBI (reduced ten-bit interface) signals except MDIO (management data input/output) and MDC (management data clock). The RGMII and RTBI interfaces are defined for 2.5 V, while the GMII and TBI interfaces can be operated at 3.3 V or 2.5 V. Whether the GMII, MII, or TBI interface is operated at 3.3 or 2.5 V, the timing is compliant with the IEEE 802.3 standard. The RGMII and RTBI interfaces follow the Hewlett-Packard reduced pin-count interface for Gigabit Ethernet Physical Layer Device Specification Version 1.2a (9/22/2000). The electrical characteristics for MDIO and MDC are specified in [Section 8.3, “Ethernet Management Interface Electrical Characteristics.”](#)

8.1.1 TSEC DC Electrical Characteristics

All GMII, MII, TBI, RGMII, and RTBI drivers and receivers comply with the DC parametric attributes specified in [Table 18](#) and [Table 19](#). The potential applied to the input of a GMII, MII, TBI, RGMII, or RTBI receiver may exceed the potential of the receiver’s power supply (for example, a GMII driver powered from a 3.6-V supply driving V_{OH} into a GMII receiver powered from a 2.5-V supply). Tolerance for dissimilar GMII driver and receiver supply potentials is implicit in these specifications. The RGMII and RTBI signals are based on a 2.5-V CMOS interface voltage as defined by JEDEC EIA/JESD8-5.

Table 18. GMII, MII, and TBI DC Electrical Characteristics

Parameter	Symbol	Conditions		Min	Max	Unit
Supply voltage 3.3 V	LV_{DD}	—		3.13	3.47	V
Output high voltage	V_{OH}	$I_{OH} = -4.0 \text{ mA}$	$LV_{DD} = \text{Min}$	2.40	$LV_{DD} + 0.3$	V
Output low voltage	V_{OL}	$I_{OL} = 4.0 \text{ mA}$	$LV_{DD} = \text{Min}$	GND	0.50	V
Input high voltage	V_{IH}	—	—	1.70	$LV_{DD} + 0.3$	V
Input low voltage	V_{IL}	—	—	-0.3	0.90	V
Input high current	I_{IH}	$V_{IN}^1 = LV_{DD}$		—	40	μA
Input low current	I_{IL}	$V_{IN}^1 = \text{GND}$		-600	—	μA

Note:

1. The symbol V_{IN} , in this case, represents the LV_{IN} symbol referenced in [Table 1](#) and [Table 2](#).

Table 19. GMII, MII, RGMII RTBI, and TBI DC Electrical Characteristics

Parameters	Symbol	Min	Max	Unit
Supply voltage 2.5 V	LV_{DD}	2.37	2.63	V
Output high voltage ($LV_{DD} = \text{Min}$, $I_{OH} = -1.0 \text{ mA}$)	V_{OH}	2.00	$LV_{DD} + 0.3$	V
Output low voltage ($LV_{DD} = \text{Min}$, $I_{OL} = 1.0 \text{ mA}$)	V_{OL}	$\text{GND} - 0.3$	0.40	V
Input high voltage ($LV_{DD} = \text{Min}$)	V_{IH}	1.70	$LV_{DD} + 0.3$	V
Input low voltage ($LV_{DD} = \text{Min}$)	V_{IL}	-0.3	0.70	V
Input high current ($V_{IN}^1 = LV_{DD}$)	I_{IH}	—	10	μA
Input low current ($V_{IN}^1 = \text{GND}$)	I_{IL}	-15	—	μA

Note:

1. Note that the symbol V_{IN} , in this case, represents the LV_{IN} symbol referenced in [Table 1](#) and [Table 2](#).

8.2 GMII, MII, TBI, RGMII, and RTBI AC Timing Specifications

The AC timing specifications for GMII, MII, TBI, RGMII, and RTBI are presented in this section.

8.2.1 GMII AC Timing Specifications

This section describes the GMII transmit and receive AC timing specifications.

8.2.2 GMII Transmit AC Timing Specifications

Table 20 provides the GMII transmit AC timing specifications.

Table 20. GMII Transmit AC Timing Specifications

At recommended operating conditions with LV_{DD} of 3.3 V \pm 5%.

Parameter/Condition	Symbol ¹	Min	Typ	Max	Unit
GTX_CLK clock period	t_{GTX}	—	8.0	—	ns
GTX_CLK duty cycle	t_{GTXH}/t_{GTX}	40	—	60	%
GMII data TXD[7:0], TX_ER, TX_EN setup time	t_{GTKHDV}	2.5	—	—	ns
GTX_CLK to GMII data TXD[7:0], TX_ER, TX_EN delay	t_{GTKHDX}	0.5	—	5.0	ns
GTX_CLK data clock rise and fall times	$t_{GTXR}^3, t_{GTXF}^{2,4}$	—	—	1.0	ns

Notes:

1. The symbols used for timing specifications herein follow the pattern $t_{(first\ two\ letters\ of\ functional\ block)(signal)(state)\ (reference)(state)}$ for inputs and $t_{(first\ two\ letters\ of\ functional\ block)(reference)(state)(signal)(state)}$ for outputs. For example, t_{GTKHDV} symbolizes GMII transmit timing (GT) with respect to the t_{GTX} clock reference (K) going to the high state (H) relative to the time date input signals (D) reaching the valid state (V) to state or setup time. Also, t_{GTKHDX} symbolizes GMII transmit timing (GT) with respect to the t_{GTX} clock reference (K) going to the high state (H) relative to the time date input signals (D) going invalid (X) or hold time. Note that, in general, the clock reference symbol representation is based on three letters representing the clock of a particular functional. For example, the subscript of t_{GTX} represents the GMII(G) transmit (TX) clock. For rise and fall times, the latter convention is used with the appropriate letter: R (rise) or F (fall).
2. Signal timings are measured at 0.7 V and 1.9 V voltage levels.
3. Guaranteed by characterization.
4. Guaranteed by design.

Figure 7 shows the GMII transmit AC timing diagram.

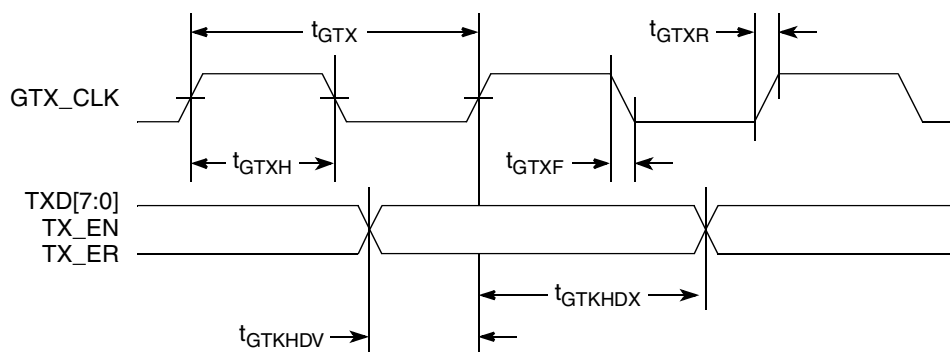


Figure 7. GMII Transmit AC Timing Diagram

8.2.3.2 MII Receive AC Timing Specifications

Table 23 provides the MII receive AC timing specifications.

Table 23. MII Receive AC Timing Specifications

At recommended operating conditions with V_{DD} of $3.3\text{ V} \pm 5\%$.

Parameter/Condition	Symbol ¹	Min	Typ	Max	Unit
RX_CLK clock period 10 Mbps	t_{MRX}^2	—	400	—	ns
RX_CLK clock period 100 Mbps	t_{MRX}	—	40	—	ns
RX_CLK duty cycle	t_{MRXH}/t_{MRX}	35	—	65	%
RXD[3:0], RX_DV, RX_ER setup time to RX_CLK	t_{MRDVKH}	10.0	—	—	ns
RXD[3:0], RX_DV, RX_ER hold time to RX_CLK	t_{MRDXKH}	10.0	—	—	ns
RX_CLK clock rise and fall time	$t_{MRXR}, t_{MRXF}^{2,3}$	1.0	—	4.0	ns

Notes:

- The symbols used for timing specifications herein follow the pattern of $t_{\text{(first two letters of functional block)(signal)(state) (reference)(state)}}$ for inputs and $t_{\text{(first two letters of functional block)(reference)(state)(signal)(state)}}$ for outputs. For example, t_{MRDVKH} symbolizes MII receive timing (MR) with respect to the time data input signals (D) reach the valid state (V) relative to the t_{MRX} clock reference (K) going to the high (H) state or setup time. Also, t_{MRDXKL} symbolizes MII receive timing (GR) with respect to the time data input signals (D) went invalid (X) relative to the t_{MRX} clock reference (K) going to the low (L) state or hold time. Note that, in general, the clock reference symbol representation is based on three letters representing the clock of a particular functional. For example, the subscript of t_{MRX} represents the MII (M) receive (RX) clock. For rise and fall times, the latter convention is used with the appropriate letter: R (rise) or F (fall).
- Signal timings are measured at 0.7 V and 1.9 V voltage levels.
- Guaranteed by design.

Figure 11 shows the MII receive AC timing diagram.

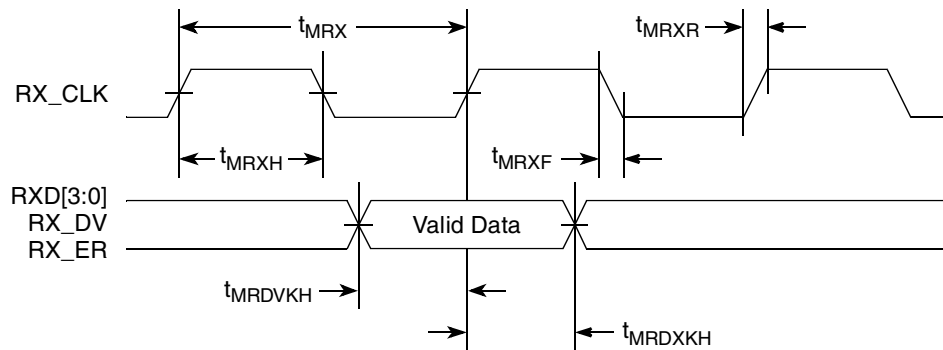


Figure 11. MII Receive AC Timing Diagram

Figure 15 shows the MII management AC timing diagram.

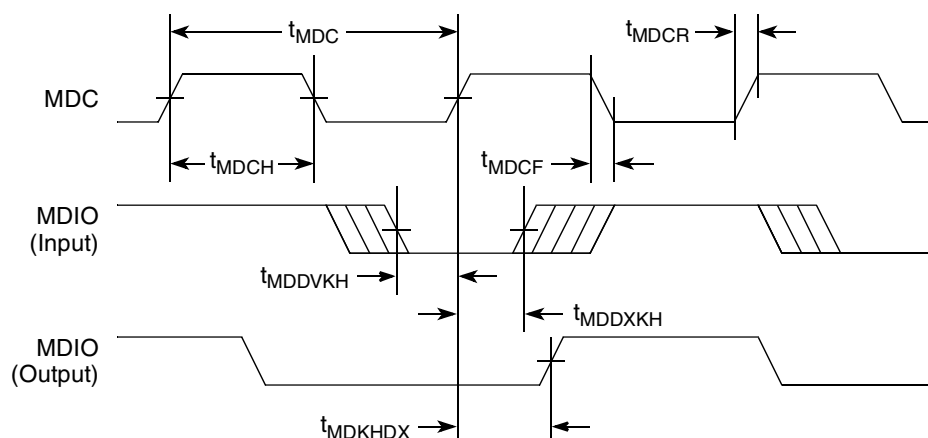


Figure 15. MII Management Interface Timing Diagram

9 Local Bus

This section describes the DC and AC electrical specifications for the local bus interface of the MPC8555E.

9.1 Local Bus DC Electrical Characteristics

Table 29 provides the DC electrical characteristics for the local bus interface.

Table 29. Local Bus DC Electrical Characteristics

Parameter	Symbol	Test Condition	Min	Max	Unit
High-level input voltage	V_{IH}	$V_{OUT} \geq V_{OH} \text{ (min) or } V_{OUT} \leq V_{OL} \text{ (max)}$	2	$OV_{DD} + 0.3$	V
Low-level input voltage	V_{IL}		-0.3	0.8	V
Input current	I_{IN}	$V_{IN}^1 = 0 \text{ V or } V_{IN} = V_{DD}$	—	± 5	μA
High-level output voltage	V_{OH}	$OV_{DD} = \text{min, } I_{OH} = -2\text{mA}$	$OV_{DD} - 0.2$	—	V
Low-level output voltage	V_{OL}	$OV_{DD} = \text{min, } I_{OL} = 2\text{mA}$	—	0.2	V

Note:

1. Note that the symbol V_{IN} , in this case, represents the OV_{IN} symbol referenced in Table 1 and Table 2.

Table 30. Local Bus General Timing Parameters—DLL Enabled (continued)

Parameter	Configuration ⁷	Symbol ¹	Min	Max	Unit	Notes
Local bus clock to output high impedance for LAD/LDP	$\overline{\text{LWE}}[0:1] = 00$	t_{LBKHOZ2}	—	2.8	ns	5, 9
	$\overline{\text{LWE}}[0:1] = 11$ (default)			4.2		

Notes:

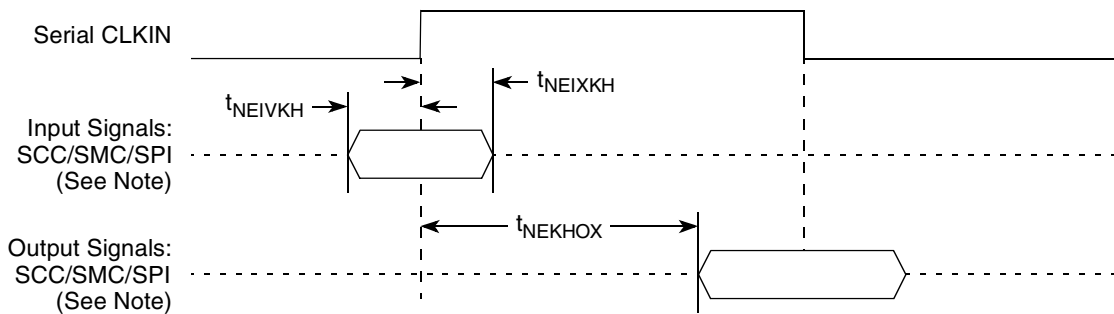
1. The symbols used for timing specifications herein follow the pattern of $t_{(\text{First two letters of functional block})(\text{signal})(\text{state})}$ (reference)(state) for inputs and $t_{(\text{First two letters of functional block})(\text{reference})(\text{state})(\text{signal})(\text{state})}$ for outputs. For example, t_{LBIXKH1} symbolizes local bus timing (LB) for the input (I) to go invalid (X) with respect to the time the t_{LBK} clock reference (K) goes high (H), in this case for clock one(1). Also, t_{LBKHOX} symbolizes local bus timing (LB) for the t_{LBK} clock reference (K) to go high (H), with respect to the output (O) going invalid (X) or output hold time.
2. All timings are in reference to LSYNC_IN for DLL enabled mode.
3. All signals are measured from $\text{OV}_{\text{DD}}/2$ of the rising edge of LSYNC_IN for DLL enabled to $0.4 \times \text{OV}_{\text{DD}}$ of the signal in question for 3.3-V signaling levels.
4. Input timings are measured at the pin.
5. For purposes of active/float timing measurements, the Hi-Z or off state is defined to be when the total current delivered through the component pin is less than or equal to the leakage current specification.
6. The value of t_{LBOTOT} is defined as the sum of 1/2 or 1 ccb_clk cycle as programmed by LBCR[AHD], and the number of local bus buffer delays used as programmed at power-on reset with configuration pins $\overline{\text{LWE}}[0:1]$.
7. Maximum possible clock skew between a clock LCLK[m] and a relative clock LCLK[n]. Skew measured between complementary signals at $\text{OV}_{\text{DD}}/2$.
8. Guaranteed by characterization.
9. Guaranteed by design.

Table 31 describes the general timing parameters of the local bus interface of the MPC8555E with the DLL bypassed.

Table 31. Local Bus General Timing Parameters—DLL Bypassed

Parameter	Configuration ⁷	Symbol ¹	Min	Max	Unit	Notes
Local bus cycle time		t_{LBK}	6.0	—	ns	2
Internal launch/capture clock to LCLK delay		t_{LBKHK1}	1.8	3.4	ns	8
LCLK[n] skew to LCLK[m] or LSYNC_OUT		t_{LBKSKEW}	—	150	ps	7, 9
Input setup to local bus clock (except LUPWAIT)		t_{LBIVKH1}	5.2	—	ns	3, 4
LUPWAIT input setup to local bus clock		t_{LBIVKH2}	5.1	—	ns	3, 4
Input hold from local bus clock (except LUPWAIT)		t_{LBIXKH1}	−1.3	—	ns	3, 4
LUPWAIT input hold from local bus clock		t_{LBIXKH2}	−0.8	—	ns	3, 4
LAL output transition to LAD/LDP output transition (LATCH hold time)		t_{LBOTOT}	1.5	—	ns	6
Local bus clock to output valid (except LAD/LDP and LAL)	$\overline{\text{LWE}}[0:1] = 00$	t_{LBKLOV1}	—	0.5	ns	3
	$\overline{\text{LWE}}[0:1] = 11$ (default)			2.0		
Local bus clock to data valid for LAD/LDP	$\overline{\text{LWE}}[0:1] = 00$	t_{LBKLOV2}	—	0.7	ns	3
	$\overline{\text{LWE}}[0:1] = 11$ (default)			2.2		

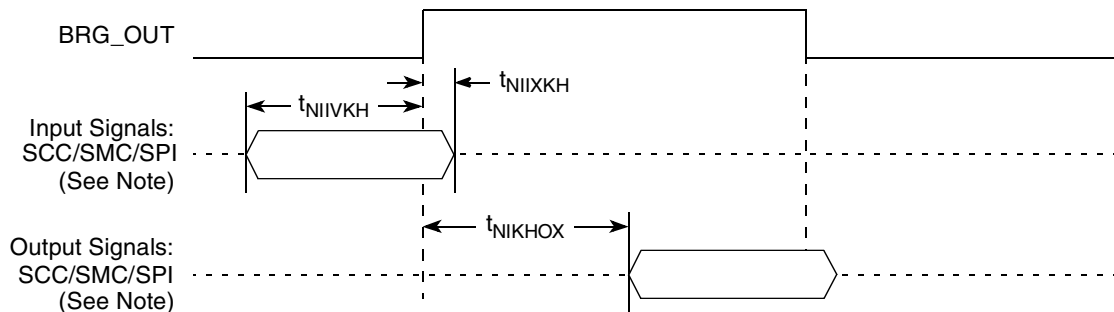
Figure 27 shows the SCC/SMC/SPI external clock.



Note: The clock edge is selectable on SCC and SPI.

Figure 27. SCC/SMC/SPI AC Timing External Clock Diagram

Figure 28 shows the SCC/SMC/SPI internal clock.



Note: The clock edge is selectable on SCC and SPI.

Figure 28. SCC/SMC/SPI AC Timing Internal Clock Diagram

NOTE

- ¹ SPI AC timings are internal mode when it is master because SPICLK is an output, and external mode when it is slave.
- ² SPI AC timings refer always to SPICLK.

Figure 32 provides the AC test load for TDO and the boundary-scan outputs of the MPC8555E.

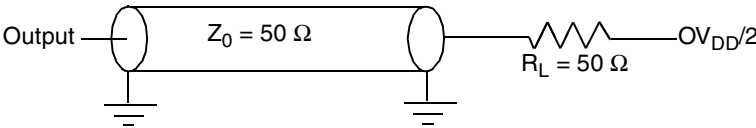


Figure 32. AC Test Load for the JTAG Interface

Figure 33 provides the JTAG clock input timing diagram.

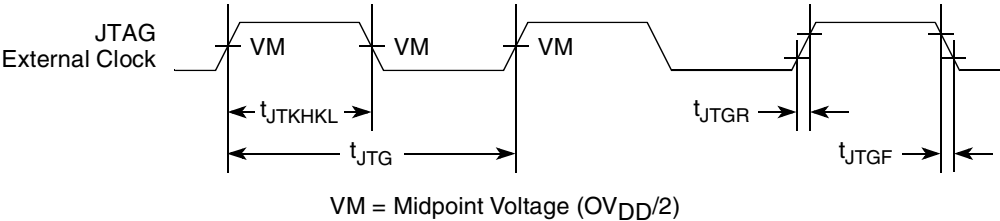


Figure 33. JTAG Clock Input Timing Diagram

Figure 34 provides the $\overline{\text{TRST}}$ timing diagram.

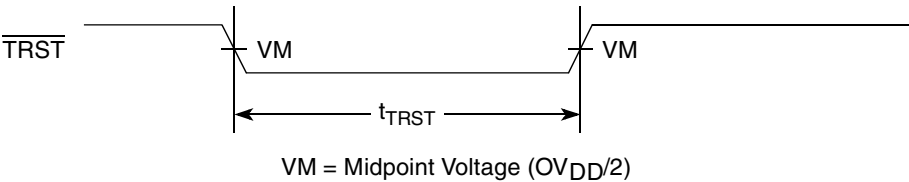


Figure 34. $\overline{\text{TRST}}$ Timing Diagram

Figure 35 provides the boundary-scan timing diagram.

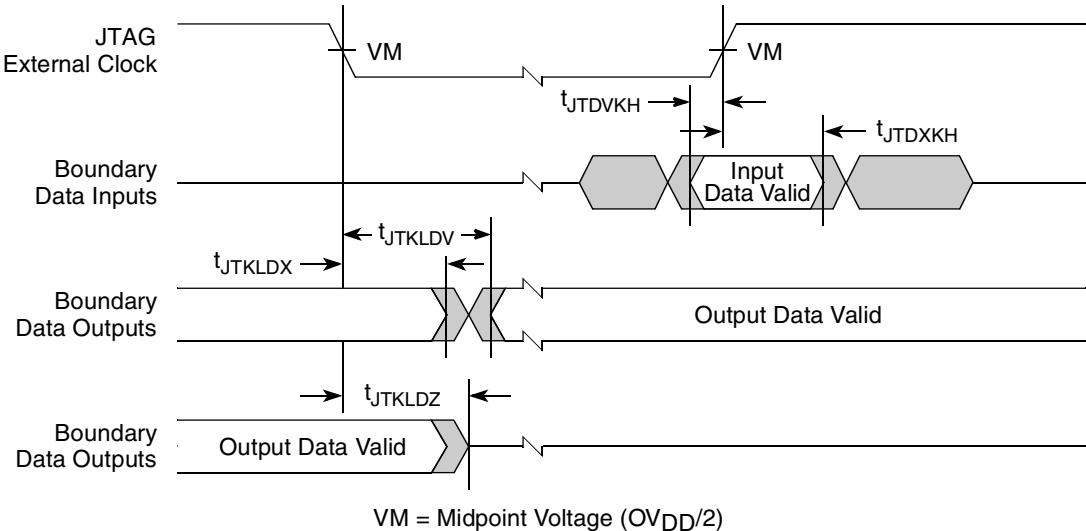


Figure 35. Boundary-Scan Timing Diagram

Figure 40 shows the PCI input AC timing conditions.

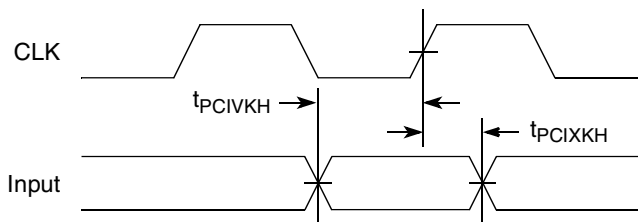


Figure 40. PCI Input AC Timing Measurement Conditions

Figure 41 shows the PCI output AC timing conditions.

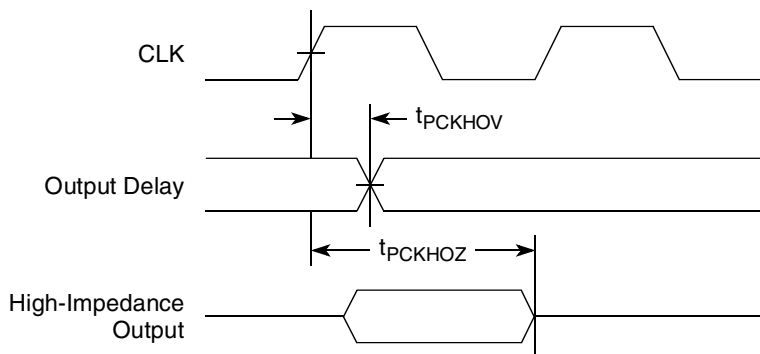


Figure 41. PCI Output AC Timing Measurement Condition

14 Package and Pin Listings

This section details package parameters, pin assignments, and dimensions.

14.1 Package Parameters for the MPC8555E FC-PBGA

The package parameters are as provided in the following list. The package type is 29 mm × 29 mm, 783 flip chip plastic ball grid array (FC-PBGA).

Die size	8.7 mm × 9.3 mm × 0.75 mm
Package outline	29 mm × 29 mm
Interconnects	783
Pitch	1 mm
Minimum module height	3.07 mm
Maximum module height	3.75 mm
Solder Balls	62 Sn/36 Pb/2 Ag
Ball diameter (typical)	0.5 mm

14.3 Pinout Listings

Table 43 provides the pin-out listing for the MPC8555E, 783 FC-PBGA package.

Table 43. MPC8555E Pinout Listing

Signal	Package Pin Number	Pin Type	Power Supply	Notes
PCI1 and PCI2 (one 64-bit or two 32-bit)				
PCI1_AD[63:32], PCI2_AD[31:0]	AA14, AB14, AC14, AD14, AE14, AF14, AG14, AH14, V15, W15, Y15, AA15, AB15, AC15, AD15, AG15, AH15, V16, W16, AB16, AC16, AD16, AE16, AF16, V17, W17, Y17, AA17, AB17, AE17, AF17, AF18	I/O	OV _{DD}	17
PCI1_AD[31:0]	AH6, AD7, AE7, AH7, AB8, AC8, AF8, AG8, AD9, AE9, AF9, AG9, AH9, W10, Y10, AA10, AE11, AF11, AG11, AH11, V12, W12, Y12, AB12, AD12, AE12, AG12, AH12, V13, Y13, AB13, AC13	I/O	OV _{DD}	17
PCI_C_BE64[7:4] PCI2_C_BE[3:0]	AG13, AH13, V14, W14	I/O	OV _{DD}	17
PCI_C_BE64[3:0] PCI1_C_BE[3:0]	AH8, AB10, AD11, AC12	I/O	OV _{DD}	17
PCI1_PAR	AA11	I/O	OV _{DD}	—
PCI1_PAR64/PCI2_PAR	Y14	I/O	OV _{DD}	—
PCI1_FRAME	AC10	I/O	OV _{DD}	2
PCI1_TRDY	AG10	I/O	OV _{DD}	2
PCI1_IRDY	AD10	I/O	OV _{DD}	2
PCI1_STOP	V11	I/O	OV _{DD}	2
PCI1_DEVSEL	AH10	I/O	OV _{DD}	2
PCI1_IDSEL	AA9	I	OV _{DD}	—
PCI1_REQ64/PCI2_FRAME	AE13	I/O	OV _{DD}	5, 10
PCI1_ACK64/PCI2_DEVSEL	AD13	I/O	OV _{DD}	2
PCI1_PERR	W11	I/O	OV _{DD}	2
PCI1_SERR	Y11	I/O	OV _{DD}	2, 4
PCI1_REQ[0]	AF5	I/O	OV _{DD}	—
PCI1_REQ[1:4]	AF3, AE4, AG4, AE5	I	OV _{DD}	—
PCI1_GNT[0]	AE6	I/O	OV _{DD}	—
PCI1_GNT[1:4]	AG5, AH5, AF6, AG6	O	OV _{DD}	5, 9
PCI1_CLK	AH25	I	OV _{DD}	—
PCI2_CLK	AH27	I	OV _{DD}	—
PCI2_GNT[0]	AC18	I/O	OV _{DD}	—

Table 43. MPC8555E Pinout Listing (continued)

Signal	Package Pin Number	Pin Type	Power Supply	Notes
IRQ[0:7]	AA18, Y18, AB18, AG24, AA21, Y19, AA19, AG25	I	OV _{DD}	—
IRQ8	AB20	I	OV _{DD}	9
IRQ9/DMA_DREQ3	Y20	I	OV _{DD}	1
IRQ10/DMA_DACK3	AF26	I/O	OV _{DD}	1
IRQ11/DMA_DDONE3	AH24	I/O	OV _{DD}	1
IRQ_OUT	AB21	O	OV _{DD}	2, 4
Ethernet Management Interface				
EC_MDC	F1	O	OV _{DD}	5, 9
EC_MDIO	E1	I/O	OV _{DD}	—
Gigabit Reference Clock				
EC_GTX_CLK125	E2	I	LV _{DD}	—
Three-Speed Ethernet Controller (Gigabit Ethernet 1)				
TSEC1_TXD[7:4]	A6, F7, D7, C7	O	LV _{DD}	—
TSEC1_TXD[3:0]	B7, A7, G8, E8	O	LV _{DD}	9, 18
TSEC1_TX_EN	C8	O	LV _{DD}	11
TSEC1_TX_ER	B8	O	LV _{DD}	—
TSEC1_TX_CLK	C6	I	LV _{DD}	—
TSEC1_GTX_CLK	B6	O	LV _{DD}	—
TSEC1_CRS	C3	I	LV _{DD}	—
TSEC1_COL	G7	I	LV _{DD}	—
TSEC1_RXD[7:0]	D4, B4, D3, D5, B5, A5, F6, E6	I	LV _{DD}	—
TSEC1_RX_DV	D2	I	LV _{DD}	—
TSEC1_RX_ER	E5	I	LV _{DD}	—
TSEC1_RX_CLK	D6	I	LV _{DD}	—
Three-Speed Ethernet Controller (Gigabit Ethernet 2)				
TSEC2_TXD[7:4]	B10, A10, J10, K11	O	LV _{DD}	—
TSEC2_TXD[3:0]	J11, H11, G11, E11	O	LV _{DD}	5, 9, 18
TSEC2_TX_EN	B11	O	LV _{DD}	11
TSEC2_TX_ER	D11	O	LV _{DD}	—
TSEC2_TX_CLK	D10	I	LV _{DD}	—
TSEC2_GTX_CLK	C10	O	LV _{DD}	—

Table 43. MPC8555E Pinout Listing (continued)

Signal	Package Pin Number	Pin Type	Power Supply	Notes
PB[18:31]	P7, P6, P5, P4, P3, P2, P1, R1, R2, R3, R4, R5, R6, R7	I/O	OV _{DD}	—
PC[0, 1, 4–29]	R8, R9, T9, T6, T5, T4, T1, U1, U2, U3, U4, U7, U8, U9, U10, V9, V6, V5, V4, V3, V2, V1, W1, W2, W3, W6, W7, W8	I/O	OV _{DD}	—
PD[7, 14–25, 29–31]	Y4, AA2, AA1, AB1, AB2, AB3, AB5, AB6, AC7, AC4, AC3, AC2, AC1, AD6, AE3, AE2	I/O	OV _{DD}	—

Notes:

1. All multiplexed signals are listed only once and do not re-occur. For example, $\overline{\text{LCS5/DMA_REQ2}}$ is listed only once in the Local Bus Controller Interface section, and is not mentioned in the DMA section even though the pin also functions as $\overline{\text{DMA_REQ2}}$.
2. Recommend a weak pull-up resistor (2–10 k Ω) be placed on this pin to OV_{DD}.
3. TEST_SEL0 must be pulled-high, TEST_SEL1 must be tied to ground.
4. This pin is an open drain signal.
5. This pin is a reset configuration pin. It has a weak internal pull-up P-FET which is enabled only when the MPC8555E is in the reset state. This pull-up is designed such that it can be overpowered by an external 4.7-k Ω pull-down resistor. If an external device connected to this pin might pull it down during reset, then a pull-up or active driver is needed if the signal is intended to be high during reset.
6. Treat these pins as no connects (NC) unless using debug address functionality.
7. The value of LA[28:31] during reset sets the CCB clock to SYSCCLK PLL ratio. These pins require 4.7-k Ω pull-up or pull-down resistors. See [Section 15.2, “Platform/System PLL Ratio.”](#)
8. The value of LALE and LGPL2 at reset set the e500 core clock to CCB Clock PLL ratio. These pins require 4.7-k Ω pull-up or pull-down resistors. See the [Section 15.3, “e500 Core PLL Ratio.”](#)
9. Functionally, this pin is an output, but structurally it is an I/O because it either samples configuration input during reset or because it has other manufacturing test functions. This pin therefore is described as an I/O for boundary scan.
10. This pin functionally requires a pull-up resistor, but during reset it is a configuration input that controls 32- vs. 64-bit PCI operation. Therefore, it must be actively driven low during reset by reset logic if the device is to be configured to be a 64-bit PCI device. Refer to the *PCI Specification*.
11. This output is actively driven during reset rather than being three-stated during reset.
12. These JTAG pins have weak internal pull-up P-FETs that are always enabled.
13. These pins are connected to the V_{DD}/GND planes internally and may be used by the core power supply to improve tracking and regulation.
14. Internal thermally sensitive resistor.
15. No connections should be made to these pins.
16. These pins are not connected for any functional use.
17. PCI specifications recommend that a weak pull-up resistor (2–10 k Ω) be placed on the higher order pins to OV_{DD} when using 64-bit buffer mode (pins PCI_AD[63:32] and $\overline{\text{PCI2_C_BE}}$ [7:4]).
18. If this pin is connected to a device that pulls down during reset, an external pull-up is required to that is strong enough to pull this signal to a logic 1 during reset.
19. Recommend a pull-up resistor (~1 k Ω) be placed on this pin to OV_{DD}.
20. These are test signals for factory use only and must be pulled up (100 Ω to 1k Ω) to OV_{DD} for normal machine operation.
21. If this signal is used as both an input and an output, a weak pull-up (~10k Ω) is required on this pin.
22. MSYNC_IN and MSYNC_OUT should be connected together for proper operation.

15 Clocking

This section describes the PLL configuration of the MPC8555E. Note that the platform clock is identical to the CCB clock.

15.1 Clock Ranges

[Table 44](#) provides the clocking specifications for the processor core and [Table 44](#) provides the clocking specifications for the memory bus.

Table 44. Processor Core Clocking Specifications

Characteristic	Maximum Processor Core Frequency										Unit	Notes
	533 MHz		600 MHz		667 MHz		833 MHz		1000 MHz			
	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max		
e500 core processor frequency	400	533	400	600	400	667	400	833	400	1000	MHz	1, 2, 3

Notes:

1. **Caution:** The CCB to SYSCLK ratio and e500 core to CCB ratio settings must be chosen such that the resulting SYSCLK frequency, e500 (core) frequency, and CCB frequency do not exceed their respective maximum or minimum operating frequencies. Refer to [Section 15.2, “Platform/System PLL Ratio,”](#) and [Section 15.3, “e500 Core PLL Ratio,”](#) for ratio settings.
- 2.)The minimum e500 core frequency is based on the minimum platform frequency of 200 MHz.
3. 1000 MHz frequency supports only a 1.3 V core.

Table 45. Memory Bus Clocking Specifications

Characteristic	Maximum Processor Core Frequency		Unit	Notes
	533, 600, 667, 883, 1000 MHz			
	Min	Max		
Memory bus frequency	100	166	MHz	1, 2, 3

Notes:

1. **Caution:** The CCB to SYSCLK ratio and e500 core to CCB ratio settings must be chosen such that the resulting SYSCLK frequency, e500 (core) frequency, and CCB frequency do not exceed their respective maximum or minimum operating frequencies. Refer to [Section 15.2, “Platform/System PLL Ratio,”](#) and [Section 15.3, “e500 Core PLL Ratio,”](#) for ratio settings.
2. The memory bus speed is half of the DDR data rate, hence, half of the platform clock frequency.
3. 1000 MHz frequency supports only a 1.3 V core.

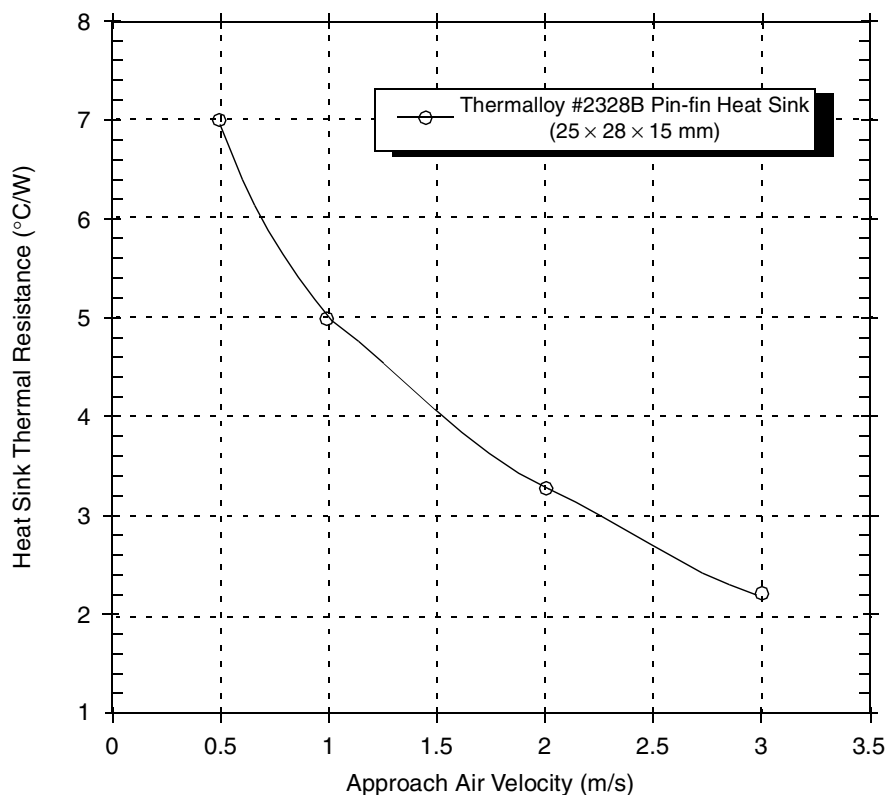


Figure 47. Thermalloy #2328B Heat Sink-to-Ambient Thermal Resistance Versus Airflow Velocity

16.2.4.2 Case 2

Every system application has different conditions that the thermal management solution must solve. As an alternate example, assume that the air reaching the component is 85 °C with an approach velocity of 1 m/sec. For a maximum junction temperature of 105 °C at 8 W, the total thermal resistance of junction to case thermal resistance plus thermal interface material plus heat sink thermal resistance must be less than 2.5 °C/W. The value of the junction to case thermal resistance in [Table 49](#) includes the thermal interface resistance of a thin layer of thermal grease as documented in footnote 4 of the table. Assuming that the heat sink is flat enough to allow a thin layer of grease or phase change material, then the heat sink must be less than 1.5 °C/W.

Millennium Electronics (MEI) has tooled a heat sink M THERM-1051 for this requirement assuming a compactPCI environment at 1 m/sec and a heat sink height of 12 mm. The MEI solution is illustrated in [Figure 48](#) and [Figure 49](#). This design has several significant advantages:

- The heat sink is clipped to a plastic frame attached to the application board with screws or plastic inserts at the corners away from the primary signal routing areas.
- The heat sink clip is designed to apply the force holding the heat sink in place directly above the die at a maximum force of less than 10 lbs.
- For applications with significant vibration requirements, silicone damping material can be applied between the heat sink and plastic frame.

Figure 50 shows the PLL power supply filter circuit.

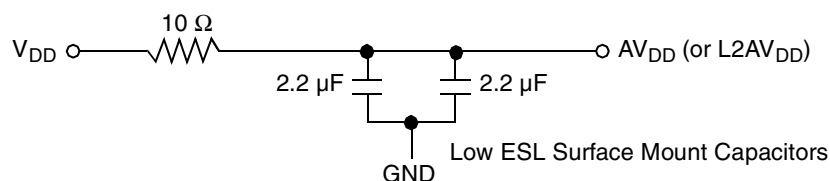


Figure 50. PLL Power Supply Filter Circuit

17.3 Decoupling Recommendations

Due to large address and data buses, and high operating frequencies, the MPC8555E can generate transient power surges and high frequency noise in its power supply, especially while driving large capacitive loads. This noise must be prevented from reaching other components in the MPC8555E system, and the MPC8555E itself requires a clean, tightly regulated source of power. Therefore, it is recommended that the system designer place at least one decoupling capacitor at each V_{DD} , OV_{DD} , GV_{DD} , and LV_{DD} pins of the MPC8555E. These decoupling capacitors should receive their power from separate V_{DD} , OV_{DD} , GV_{DD} , LV_{DD} , and GND power planes in the PCB, utilizing short traces to minimize inductance. Capacitors may be placed directly under the device using a standard escape pattern. Others may surround the part.

These capacitors should have a value of 0.01 or 0.1 μF . Only ceramic SMT (surface mount technology) capacitors should be used to minimize lead inductance, preferably 0402 or 0603 sizes.

In addition, it is recommended that there be several bulk storage capacitors distributed around the PCB, feeding the V_{DD} , OV_{DD} , GV_{DD} , and LV_{DD} planes, to enable quick recharging of the smaller chip capacitors. These bulk capacitors should have a low ESR (equivalent series resistance) rating to ensure the quick response time necessary. They should also be connected to the power and ground planes through two vias to minimize inductance. Suggested bulk capacitors—100–330 μF (AVX TPS tantalum or Sanyo OSCON).

17.4 Connection Recommendations

To ensure reliable operation, it is highly recommended to connect unused inputs to an appropriate signal level. Unused active low inputs should be tied to OV_{DD} , GV_{DD} , or LV_{DD} as required. Unused active high inputs should be connected to GND. All NC (no-connect) signals must remain unconnected.

Power and ground connections must be made to all external V_{DD} , GV_{DD} , LV_{DD} , OV_{DD} , and GND pins of the MPC8555E.

17.5 Output Buffer DC Impedance

The MPC8555E drivers are characterized over process, voltage, and temperature. For all buses, the driver is a push-pull single-ended driver type (open drain for I^2C).

To measure Z_0 for the single-ended drivers, an external resistor is connected from the chip pad to OV_{DD} or GND. Then, the value of each resistor is varied until the pad voltage is $OV_{DD}/2$ (see Figure 51). The output impedance is the average of two components, the resistances of the pull-up and pull-down devices.

The COP function of these processors allow a remote computer system (typically, a PC with dedicated hardware and debugging software) to access and control the internal operations of the processor. The COP interface connects primarily through the JTAG port of the processor, with some additional status monitoring signals. The COP port requires the ability to independently assert $\overline{\text{HRESET}}$ or $\overline{\text{TRST}}$ in order to fully control the processor. If the target system has independent reset sources, such as voltage monitors, watchdog timers, power supply failures, or push-button switches, then the COP reset signals must be merged into these signals with logic.

The arrangement shown in Figure 52 allows the COP port to independently assert $\overline{\text{HRESET}}$ or $\overline{\text{TRST}}$, while ensuring that the target can drive $\overline{\text{HRESET}}$ as well.

The COP interface has a standard header, shown in Figure 52, for connection to the target system, and is based on the 0.025" square-post, 0.100" centered header assembly (often called a Berg header). The connector typically has pin 14 removed as a connector key.

The COP header adds many benefits such as breakpoints, watchpoints, register and memory examination/modification, and other standard debugger features. An inexpensive option can be to leave the COP header unpopulated until needed.

There is no standardized way to number the COP header; consequently, many different pin numbers have been observed from emulator vendors. Some are numbered top-to-bottom then left-to-right, while others use left-to-right then top-to-bottom, while still others number the pins counter clockwise from pin 1 (as with an IC). Regardless of the numbering, the signal placement recommended in Figure 52 is common to all known emulators.

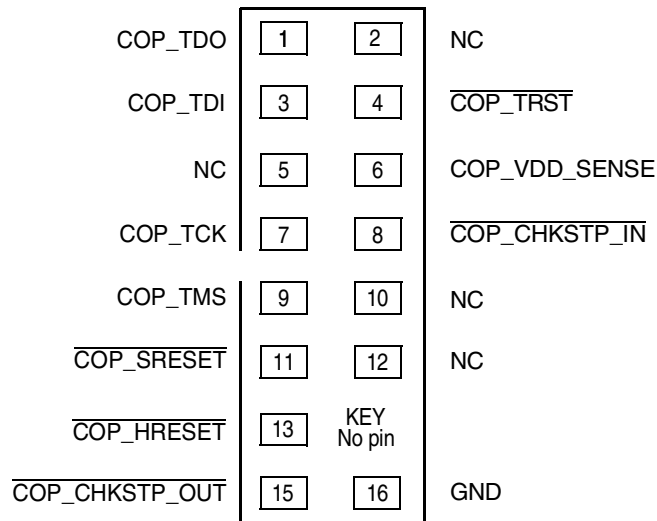


Figure 52. COP Connector Physical Pinout